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|-----------------------------------|--|--------------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination SUK, SANG MOON | |
| | | Examiner Stephen G. Sherman | Art Unit 2629 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-5,831,837 | 11-1998 | Coyne et al. | 363/21.08 |
| * | B | US-6,882,134 | 04-2005 | Balakrishnan et al. | 323/284 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------------|----------------|
| | N | JP 2002199613 A | 07-2002 | Japan | AKIYASU, HITOSHI | |
| | O | JP 05137335 A | 06-1993 | Japan | INAO et al. | |
| | P | JP 05328718 A | 12-1993 | Japan | KOIZUMI et al. | |
| | Q | JP 2000232777 A | 08-2000 | Japan | HAGA et al. | |
| | R | JP 06292360 A | 10-1994 | Japan | RI et al. | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.